# Bibliographically Coupled Patents: Their Temporal Pattern and Combined Relevance 

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## Outlines

$>$ Relatedness between patents
$>$ Temporal pattern of BCed patents
$>$ Patent and Reference Expansion
$>$ Combined Relevance

## Relatedness between patents

- Patent bibliometric works often involve the detection and measurement of relatedness between patents



## Relatedness between patents

- Then, we may observe cooperation/competition relationship, knowledge exchange, ...between entities



## Approaches in detecting and measuring patent relatedness

- Text-based
- Classification-based
- Citation-based


## Citation-based approaches

- Direct citation (DC)
- Co-citation (CC)
- Bibliographic coupling (BC)


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## Temporal pattern of BCed patents

- Age and Span of Patent Pairs
- Age: how long ago the later patent $\left(\mathrm{P}_{\mathrm{L}}\right)$ is issued
- Span: $P_{E}$ and $P_{L}$ 's distances in time


Time

## Temporal pattern of BCed patents

- Frequency distributions
- X axis: age in years;Y axis: span in years
- More reddish or bluish points reflect higher or lower counts




## Temporal pattern of BCed patents

- Average BCS and average CCS
- X axis: age in years; Y axis: span in years
- More reddish or bluish points reflect higher or lower values




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## Patent and Reference Expansion

- A field's continuously increasing numbers of accumulated patents



## Patent and Reference Expansion

- BC is more frequently found between patents issued more recently and closer in time, and their BCS also tends to be stronger



## Implication to BCS threshold

- Conventional Methods
- $P_{E}$ and $P_{L}$ have references $R E F_{E}$ and $R E F_{L}$ respectively
- Jaccard coefficient
- $\frac{\left|R E F_{E} \cap R E F_{L}\right|}{\left|R E F_{E} \cup R E F_{L}\right|} \leq \frac{\left|R E F_{E}\right|}{\left|R E F_{E} \cup R E F_{L}\right|} \leq\left|R E F_{E}\right|$
- Coupling angle (cosine similarity)
$\cdot \frac{\overrightarrow{R E F_{E}} \cdot \overrightarrow{R E F_{L}}}{\left|\overrightarrow{R E F_{E}}\right|\left|\overrightarrow{R E F_{L}}\right|}=\frac{\left|R E F_{E} \cap R E F_{L}\right|}{\left|\overrightarrow{R E F_{E}}\right|\left|\overrightarrow{R E F_{L}}\right|} \leq \frac{\left|R E F_{E}\right|}{\left|\overrightarrow{R E F_{E}}\right|\left|\overrightarrow{R E F_{L}}\right|} \leq\left|R E F_{E}\right|$
- Aged or long-spanned patent pairs are not only fewer but also inherently limited in their coupling strength


## Limitation

- Citable patent expansion and cited reference expansion contribute to the temporal pattern.
- The cited reference expansion is particularly applicable to U.S. patents, as U.S. requires full and obligatory disclosure from patent applicants.
- There is a lack of evidence that non-U.S. patents would undergo cited reference expansion of comparable degree.


## Implication to BCS threshold

- Bibliometric researchers had noticed the age and span problem.
- "an increase of the distance in time between bibliographically coupled articles leads to a diminishing pool of shared references as there is a tendency to cite the more current articles" (Jarneving, 2007b)
- Usually an observation window is set up so that bibliographically coupled research articles
- published closer (i.e., about the same age)
- within the window (i.e., within limited span) are collected and compared together (cf. Jarneving, 2007b; Glänzel, \& Czerwon, 1996).


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## Combined Relevance

- To observe the knowledge flow or to develop a representative trajectory among patents across a long period of time
- a BCS measure as much immune to their ages and spans as possible would be desirable


## Combined Relevance

- $\left(\frac{\left|R E F_{E} \cap R E F_{L}\right|}{\left|R E F_{E}\right|}\right)\left(\frac{\left|R E F_{E} \cap R E F_{L}\right|}{\left|R E F_{L}\right|}\right)=\frac{\left|R E F_{E} \cap R E F_{L}\right|^{2}}{\left|R E F_{E}\right|\left|R E F_{L}\right|}$
$-R E F_{E} \cap R E F_{L}$ is the information shared between $P_{E}$ and $P_{L}$
- Left factor: how much this shared information relevant to $P_{E}$
- Right factor: how much this shared information relevant to $P_{L}$


## Combined Relevance

- Average BCS vs. average CR
- CR's is relatively more uniform distributed across ages and span




## Combined Relevance

- Frequency distribution
- CR also retains more aged and longspanned pairs




## Combined Relevance

- CR is not ideal as observed above, but it is as simple as the conventional measures, both conceptually and computationally.
- For observing long-term knowledge dissemination or tracing overall development trajectory, CR may be an alternative.


## Thank You

